Specification Sheet for Approved

Customer Name:	
Customer Part No.:	
Ceaiya Part No:	CMPI0523D-R33M
Spec No:	L0523

[For Customer Approval Only **]**

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[RoHS Compliant Parts **]**

Approved By	Checked By	Prepared By
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1/7

[Version of Changed Record]

Rev.	Effective Date	Changed Contents	Change Reasons	Approved By		
A0	2023-07-11	New release	1	Li qing hui		

1. Scope

This specification applies to the CMPI0523D Series of wire wound SMD power inductor.

2. Product Description and Identification (Part Number)

1) Description:

CMPI0523D series of Wire wound SMD power inductor.

2) Product Identification (Part Number)









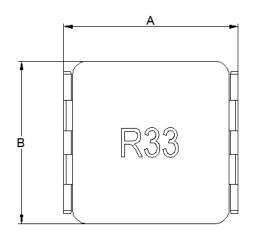
- 1 Product Series
- ② Choke Size
- ③ Initial Inductance(L @ 0A):R33=0.33μH
- 4 Inductance Tolerance:M=L+/-20%

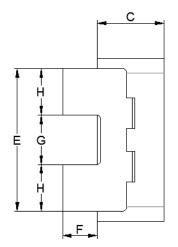
3. Electrical Characteristics

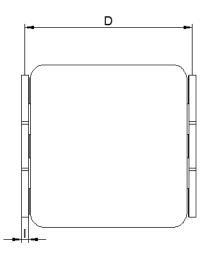
- 1) Operating temperature range (individual chip without packing): -40 $^{\circ}$ C ~ +125 $^{\circ}$ C (Including Self-heating).
- 2) Storage temperature range (On PCB): -40 $^{\circ}$ C ~ +125 $^{\circ}$ C

4. Shape and Dimensions (Unit:mm)

MECHANICAL PARAMETERS







Α	В	С	D	E	F	G	Н	
6.0±0.3	5.6±0.2	2.3±0.2	5.8±0.2	4.9±0.2	1.3Max	1.7±0.1	1.6 ±0.1	0.2±0.05

Notes:

- 1. Marking: Ink Marking
- 2. Stamping XXX :inductor

Specification Sheet for SMD Power Inductor

3. Electrical Characteristics

Part Number	L0(uH) ±20%		R(mΩ) 25°C	Isat(Amp) Irms(Amp Typ. Typ.		
	<u> </u>	Max.	Тур.	ryp.	ryp.	
CMPI0523D-R33M	0.33	4.20	3.55	18	14	

Notes:

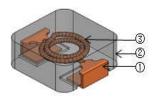
- 1. Initial Inductance (L0) Test Parameters:1MHz,1V,Idc=0.0A,+25 $^{\circ}$ C
- 2. All test data is referenced to 25°C ambient;
- 3. Rated current: Isat or Irms, whichever is smaller;
- 4. Isat(A): DC current at which the inductance drops approximate 30% from its value without current;
- 5. Irms(A): DC current that causes the temperature rise ($\triangle T$ =40 $^{\circ}$ C) from 25 $^{\circ}$ C ambient.

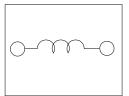
4. Reliability Test

Items	Requirements	Test Methods and Remarks
6.1 Terminal Strength	No removal or split of the termination or other defects shall occur.	Solder the inductor to the testing jig (glass epoxy board shown in Fing.6.1-1) using eutectic solder. Ther apply a force in the direction of the arrow. 10N force. Keep time: 5±2s
6.2 High Temperature	No visible mechanical damage. Inductance change: Within ±10%	 Storage Temperature :125±5°C Duration : 96 ±4 Hours Recovery : then measured at room ambient temperature after placing 24 hours.
6.3 Low Temperature	No visible mechanical damage Inductance change: Within ±10%	1) Temperature and time: -40±5°C 2) Duration: 96 [±] 4 hours 3) TRecovery: then measured at room ambient temperature after placing 24 hours.
6.4 Vibration test	No visible mechanical damage. Inductance change: Within ±10%	1) Frequency range:10Hz~55Hz~10Hz 2) Amplitude:1.5mm p-p 3) Direction:X,Y,Z 4) Time:1 minute/cycle,2hours per axis
6.5 High Temperature Storage Tested	No visible mechanical damage. Inductance change: Within ±10%	1) Storage Temperature :60±2°C 2) Relative Humidity :90-95% 3) Duration : 96 ±4 Hours 4) Recovery : then measured at room ambient temperature after placing 24 hours.
6.6 Resistance to Soldering Heat	1. No visible mechanical damage. 2. Inductance change: Within ±10% 260°C Peak 260°C max Max Ramp Up Rate=3°C/sec. Max Ramp Down Rate=6°C/sec 60~90sec. 150°C Time 25°C to Peak =8 min max Fig.6.6-1	1) Re-flowing Profile: Please refer to Fig.6.6-1 2) Test board thickness: 1.0mm 3) Test board material: glass epoxy resin 4) The chip shall be stabilized at normal condition fo 1~2 hours before measuring
6.7 Thermal Shock	1. No visible mechanical damage. 2. Inductance change: Within ±10% 105°C 30 min. Ambient Temperature 40°C Max 3 minute Fig.6.7-1	 Temperature and time: -40±3°C for 30±3 min→105°C for 30±3min, please refer to Fig.6.7-1. Transforming interval: Max, 3 minute Tested cycle: 100 cycles The chip shall be stabilized at normal condition for 1~2 hours before measuring

Specification Sheet for SMD Power Inductor

7. MATERIAL LIST

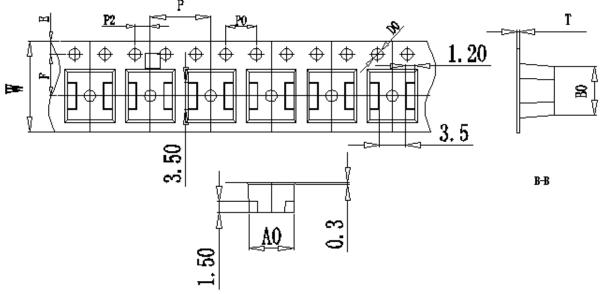




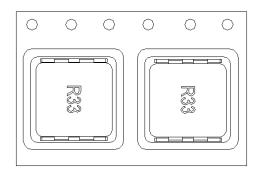
NO.	Part Name	Material
1	Electrode	Cu+Sn plating
2	Core	Metal composite core
3	Coil	Copper wire, 220 $^{\circ}\!\mathrm{C}$

8. PACKAGE INFORMATION-mm

8.1 Tape Packaging Dimensions

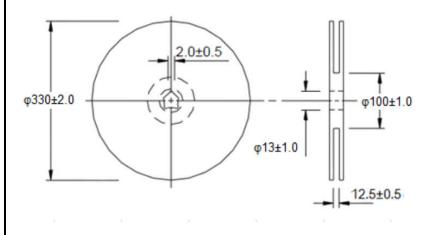


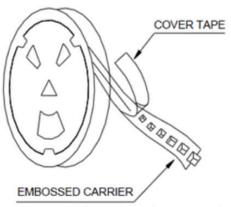
Item	W	A0	В0	K0	Р	F	Е	D0	P0	P2	T
DIM	12.0	5.9	6.4	4.0	8.0	5.5	1.75	1.5	4.0	2.0	0.40
Tole	±0.3	±0.1	±0.1	±0.1	±0.1	±0.1	±0.1	±0.1	±0.1	±0.1	Тур.



Specification Sheet for SMD Power Inductor

8.2 Reel Dimensions





Taping Quantity

800pieces/Reel